What is claim d is:

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- 1. An electrostatic chuck comprising:
- (a) a dielectric member comprising:
- (i) a first layer comprising a semiconductive material; and
- (ii) a second layer over the first layer, the second layer comprising an insulative material; and
 - (b) an electrode in the dielectric member.
- 10 2. An electrostatic chuck according to claim 1 wherein the first layer comprises a resistivity of from about 5 x $10^9 \Omega$ cm to about 8 x $10^{10} \Omega$ cm.
 - 3. An electrostatic chuck according to claim 1 wherein the second layer comprises a resistivity of at least about 1 x 10^{11} Ω cm.
 - 4. An electrostatic chuck according to claim 1 wherein the second layer comprises a resistivity of from about 1 x 10^{11} to about 1 x 10^{20} Ω cm.
- 5. An electrostatic chuck according to claim 1 wherein the first 20 layer comprises Al_2O_3 .
 - 6. An electrostatic chuck according to claim 1 wherein the first layer comprises TiO₂.
- 25 7. An electrostatic chuck according to claim 1 wherein the first layer comprises AIN.
 - 8. An electrostatic chuck according to claim 1 wherein the electrode is embedded in the first layer of the dielectric member.
 - 9. An electrostatic chuck according to claim 1 wherein the second layer comprises AIN.
- 10. An electrostatic chuck according to claim 1 wherein the second 35 layer comprises SiO₂ or ZrO₂.

- 11. An electrostatic chuck according to claim 1 wherein the second layer comprises polyimide or Teflon®.
- 12. An electrostatic chuck according to claim 1 wherein the5 dielectric member is fabricated by sintering ceramic powders.
 - 13. An electrostatic chuck comprising:

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- (a) a dielectric member comprising:
- (i) a first layer comprising a resistivity of from about $5 \times 10^9 \,\Omega$ cm to about $8 \times 10^{10} \,\Omega$ cm; and
- (ii) a second layer over the first layer, the second layer comprising a resistivity of from about 1 x 10^{11} to about 1 x 10^{20} Ω cm; and (b) an electrode in the dielectric member.
- 15 14. An electrostatic chuck according to claim 13 wherein the first layer comprises Al₂O₃.
 - 15. An electrostatic chuck according to claim 13 wherein the first layer comprises TiO₂.
 - 16. An electrostatic chuck according to claim 13 wherein the electrode is embedded in the first layer of the dielectric member.
- 17. An electrostatic chuck according to claim 13 wherein the second layer comprises SiO₂.
 - 18. An electrostatic chuck according to claim 13 wherein the second layer comprises ZrO₂.

- 19. An electrostatic chuck comprising:
 - (a) a dielectric member comprising:
- (i) a first semiconductive layer having a resistivity
 that is sufficiently low to provide (i) a charging time of less than about 3 seconds, and
 (ii) allow accumulated electrostatic charge to substantially dissipate in less than about 1 second; and
 - (ii) a second insulative layer over the first semiconductive layer, the second insulative layer having a resistivity higher than the first semiconductive layer; and
 - (b) an electrode in the dielectric member.
 - 20. An electrostatic chuck according to claim 19 wherein the first semiconductive layer comprises a resistivity of from about 5 x 10^9 Ω cm to about 8 x 10^{10} Ω cm.
 - 21. An electrostatic chuck according to claim 19 wherein the second insulative layer comprises a resistivity of from about 1 x 10^{11} to about 1 x 10^{20} Ω cm.

22. An electrostatic chuck according to claim 19 wherein the first semiconductive layer comprises Al₂O₃.

- 23. An electrostatic chuck according to claim 19 wherein the electrode is embedded in the first semiconductive layer of the dielectric member.
 - 24. An electrostatic chuck according to claim 19 wherein the second insulative layer comprises SiO₂.
- 30 25. An electrostatic chuck according to claim 19 wherein the second insulative layer comprises ZrO₂.

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